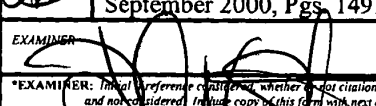


FORM PTO-1449 US DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		Atty. Docket No. 84003AF-P Customer No. 01333		Serial No. To be assigned 10/666,146		
If AFTER the later date of the first Office Action or 3 months from filing, use only with Rule 97(E) Certificate or Fee		Applicant: David L. Patton, et al				
LIST OF ART CITED BY APPLICANT <small>(Use several sheets if necessary)</small>		Filing Date Herewith 09/18/2003		Group Ad 2873		
U.S. PATENT DOCUMENTS						
All art was cited in parent application.						
Examiner Initial*	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
D/S	5,155,624	10/13/92	Flagler	359	510	
D/S	5,311,358	05/10/94	Pederson et al.	359	510	
D/S	5,406,421	04/11/95	Kashima et al.	219	121.68	
D/S	5,853,363	12/29/98	Vought	600	121	
D/S	5,910,940	06/08/99	Guerra	369	275.10	
D/S	6,024,454	02/15/00	Horan et al.	359	510	
D/S	6,094,413	07/25/00	Guerra	369	275.10	
D/S	6,221,028	04/24/01	Lieberman et al.	600	558	
D/S	6,301,055	10/09/01	Legrand et al.	359	642	
FOREIGN PATENT DOCUMENTS						
Examiner Initial*	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)						
D/S	"Imaging with Solid Immersion Lenses, Spatial Resolution, and Applications", Qiang Wu, Member, IEEE, Luke P. Ghislain, Member, IEEE, and V. B. Elings, Proceedings of the IEEE, Vol. 88, No. 9, September 2000, Pgs. 1491-1498					
EXAMINER 	DATE CONSIDERED 04/23/2004					
<small>*EXAMINER: Initial reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>						

DAVID SPECTOR
PRIMARY EXAMINER